Search Notes				

Application No.	Applicant(s)	
10/735,956	HATSCH ET AL.	
Examiner	Art Unit	
Tan V Mai	2193	

SEARCHED			
Class	Subclass	Date	Examiner
708	708-709, 702-703	3/25/2005	MAI
			-
		· · · · · · · · · · · · · · · · · · ·	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	-		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Inventor search Double Patenting Check Data Bases Search (see attached copy)	3/25/2005	MAI	